

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/528,070	AOYAMA ET AL.
	Examiner	Art Unit
	James D. Ewart	2617

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
same as	above	1/12/2007	JDE

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/528,070	AOYAMA ET AL.
	Examiner	Art Unit
	James D. Ewart	2617

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
same as	above	1/12/2007	JDE